## Electronic Systems Test Laboratory (ESTL) Test Request Worksheet

This worksheet will facilitate the development of a cost and schedule estimate for utilizing the ESTL. Please complete this form and submit to the ESTL Laboratory Manager, andy.romero-1@nasa.gov

T (ACLE)	
Test Article Expert:	Contact Information (Phone, Email, Address):
Test Objectives	
Purpose of Test:	
Proposed Start Date:	Critical Start Date:
Troposod Start Bato.	Ontiodi Start Bato.
To at Autolo	
Test Article	
Test Article Description:	
Physical Dimensions (L/W/H):	
Woightu	Cotus Timos
Weight::	Setup Time:
Support/Ancillary Equipment provided by requester:	

Test Article Handling Requirements											
Cleanliness Level:			С	Controlled Access:							
Electrosta	itic Disch	arge (ESI	D) Requir	ements:							
Special M	Conscient Maying // Londling.										
Special Moving/Handling:											
D											
Power F Input Volt			.C., Both)	:	Input \	Input Voltage Requirement (Volts):					
						. ,					
Input Power (Watts or Amps):				Number of Power Phase: Connections:							
					Conne	Connections.					
Test En	vironme	ent									
			nent table	below or	include y	your desire	ed acoust	ic profile a	as an atta	chment	
·		1		1/1		e Band (F			ı	1	
Sound	امريما	31.5	63	125	250	500	1000	2000	4000	8000	16000
Pressure	Pressure Level										
	We	eighting	ı								
A	В	C	Non	e							
				1/3	3 Octave	e Band (F	Hz)				
		31.5	40	50	63	80	100	125	160	200	250
Sound Pressure Level 315 400 500 630 800 1k 1.25k 3.15k 4k 5k 6.3k 8k 10k 12.5k		315	400	500	630	800	1k	1.25k	1.6k	2k	2.5k
		3.15k	4k	5k	6.3k	8k	10k	12.5k	16k		
Weighting											
А	В	C	Non	e							

Test Requirements					
Test Article Interface (support structure, connectors,	etc.):				
Specification(s) to be met:					
Instrumentation					
Instrumentation Provided by Test Requester:					
List the primary measurements to be made (frequen	cy, sound pressure level, sound transmission loss):				
Data Acquisition and Recording					
Number of Channels:	Audio/Video Recording (Yes/No):				
Sampling Rates:	Photographic Film (Yes/No):				
Destative Data Description (A)					
Real Time Data Processing (Yes/No):	High Speed/Low Speed:				

## Test Article Hazard Checklist

(A hazard analysis statement is required for any of the following applicable attributes of any of your provided hardware (test article, support equipment, etc.)

Hazard	Υ	Ν	Comments
Mechanical			
Handling (> 40 lbs. Or > 4 ft., any dimension)			
Instability			
Sharp Edges			
Pinch Points			
Exposed mechanisms (rotating, reciprocating, etc.)			
Pressure Systems			
Stored energy (springs, weights, flywheels, etc.)			
Ejected parts, projectiles			
Electrical			
Voltage (> 50 volts)			
Batteries			
Generation/storage (coils, magnets, capacitors, etc.)			
Electro-static sensitive devices			
Thermal			
Hot surfaces (> 113° F, 45° C)			
Heaters			
Cold surfaces (< 39° F, 4° C)			
Cooling devices			

Hazard	Υ	N	Comments
Radiation			
lonizing			
Non-lonizing			
Laser			
Microwave			
Infrared (IR)			
Ultraviolet (UV)			
Radio Frequency (RF)			
Visible light, high intensity			
Material			
Uncontained brittle materials			
Test environment incompatibility			
Contained fluids			
Toxic, corrosive, flammable fluids			
Biohazards			
Miscellaneous			
Noise level (> 85 dBA)			
Ultrasonic			